

# **RF EXPOSURE REPORT**

REPORT NO.:	SA140730D07
MODEL NO.:	F5L174
FCC ID:	K7SF5L174
<b>RECEIVED:</b>	Jul. 30, 2014
TESTED:	Aug. 22 ~ 28, 2014
ISSUED:	Aug. 29, 2014

APPLICANT: Belkin International, Inc.

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**ISSUED BY:** Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

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### RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED	
SA140730D07	Original release	Aug. 29, 2014	



#### **1. CERTIFICATION**

PRODUCT:Belkin QODE Slim Style Keyboard Case for iPadBRAND NAME:BelkinMODEL NO.:F5L174APPLICANT:Belkin International, Inc.TESTED:Aug. 22 ~ 28, 2014TEST SAMPLE:ENGINEERING SAMPLESTANDARDS:FCC Part 2 (Section 2.1093)KDB 447498 D03IEEE C95.1

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch,** and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

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PREPARED BY

(Jessica Cheng / Senior Specialist)

DATE: Aug. 29, 2014

( Rex Lai / Assistant Manager )

**DATE:** Aug. 29, 2014

APPROVED BY



### 2. EVALUATION RESULT

#### Following FCC KDB 447498 D01 "General SAR test exclusion guidance"

The corresponding SAR Exclusion Threshold condition, listed below:

- The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by: [(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] ·[√f(GHz)] ≤ 3.0 for 1-g SAR and ≤ 7.5 for 10-g extremity SAR,16 where
  - Ø f(GHz) is the RF channel transmit frequency in GHz.
  - Ø Power and distance are rounded to the nearest mW and mm before calculation.
  - Ø The result is rounded to one decimal place for comparison The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.</p>
- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
  - a) [Threshold at 50 mm in step 1) + (test separation distance 50mm)·( f(MHz)/150)] mW, at 100MHz to 1500 MHz
  - b) [Threshold at 50 mm in step 1) + (test separation distance 50 mm)  $\cdot$  10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
  - a) The threshold at the corresponding test separation distance at 100 MHz in step
    2) is multiplied by [1 + log(100/f(MHz))] for test separation distances > 50 mm
    and < 200 mm.</li>
  - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by ½ for test separation distances ≤ 50 mm.
  - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.



### 3. SAR TEST EXCLUSION THRESHOLDS

Maximum measured transmitter power:

Frequency (GHz)	Max. Power (mW)	Min. test separation distance (mm)	SAR test exclusion calculation value <sup>(NOTE 2)</sup>	1-g SAR test exclusion thresholds	Result
2.402 ~ 2.480	1.3	5	0.403	3	Pass

**NOTE:** 1. The antenna type is PCB Antenna with 2.39dBi gain.

2. Calculate SAR test exclusion thresholds from condition "1" formulas.

#### 4. CONCLUSION

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.